Docket Number:BUR920000229US2

In re application of:	: Before the Examiner:
BUFFET, et al.	:
Filed:	: Group Art Unit:
Title: METHOD FOR LOCATING IDDQ DEFECTS USING MULTIPLE CONTROLLABLE COLLAPSE CHIP CONNECTIONS CURRENT MEASUREMENT ON AN AUTOMATED TESTER	 : Intellectual Property Law Department : International Business Machines Corp. : 1000 River Street : Internal Zip 972E : Essex Junction, VT 05452
Commissioner for Patents Washington, D. C. 20231	

CERTIFICATE OF MAILING

I, hereby, certify that on the date shown below, this correspondence is being sent by:

EXPRESS MAIL

□ deposited with the United States Postal Service with sufficient postage as Express Mail in an envelope addressed to: Commissioner for Patents, Box 1450, Alexandria, VA 22313-1450. Express Mail #EV024700753US

FACSIMILE

transmitted by facsimile to the Patent and Trademark Office.

Date:

19,2003

Name

e Deborah S. Drury

Signature

Sir:

PRELIMINARY AMENDMENT

Kindly enter this amendment prior to initial examination. Any fees required in entering this divisional may be charged to Applicant's deposit account, 09-0456.